. (	Searcl	n Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/892,586	TURNER ET AL.	
Examiner	Art Unit	_
A. ml I. Chavan	2122	

	SEARCHED		
Class	Subclass	Date	Examiner
703	2,13	9/1/2007	agal agal
700	29-31	9/1/2007	ayal
706	15-16, 45	9/1/2007	appl
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST, IEEE See attached search notes	9/1/2007	ayrl
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